APR 21 2006 THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of:

David R. Battiste

Serial No.:

09/705,316

Filed:

November 3, 2000

For:

IMPROVED MONITORING AND

CONTROL OF PROCESSES FOR

MAKING 1-HEXENE

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Group Art Unit:

1764

Examiner:

Buttner, David J.

Atty. Docket: CPCM:0008/FLE

33938US00

Mail Stop Appeal Brief-Patents Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

CERTIFICATE OF TRANSMISSION OR MAILING 37 C.F.R. 1.8

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April 17, 2006

Date

Sir:

APPEAL BRIEF PURSUANT TO 37 C.F.R. §§ 41.31 AND 41.37

This Appeal Brief is being filed in furtherance to the Notice of Appeal mailed on December 29, 2005, and received by the Patent Office on January 17, 2006. Appellant respectfully requests that the Commissioner charge the requisite fee of \$500.00 for the Appeal Brief to the credit card listed on the attached PTO-2038.

Appellant hereby requests a one-month extension in the statutory period from March 17, 2006 to April 17, 2005 in accordance with 37 C.F.R. § 1.136. The Commissioner is authorized to charge the requisite fee of \$120.00 for a one-month extension of time to the credit card listed on the attached PTO-2038.

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500.00 OP 120.00 DP The Commissioner is authorized to charge any additional fees which may be required, to the credit card listed on the attached PTO-2038. Further, if the PTO-2038 is missing, if the amount listed thereon is insufficient, or if the amount is unable to be charged to the credit card for any other reason, the Commissioner is authorized to charge Deposit Account No. 06-1315; Order No. CPCM:0008/FLE (33938US00).

1. REAL PARTY IN INTEREST

The real party in interest is Chevron Phillips Chemical Company LP, the Assignee of the above-referenced application by virtue of the executed Assignment, which will be directly affected by the Board's decision in the pending appeal.

2. **RELATED APPEALS AND INTERFERENCES**

Appellant is unaware of any other appeals or interferences related to this Appeal.

The undersigned is Appellant's legal representative in this Appeal.

3. STATUS OF CLAIMS

Claims 1-5, 8-12, 30-33, and 35-37 are currently under final rejection and, thus, are the subject of this appeal.

4. **STATUS OF AMENDMENTS**

An amendment subsequent to the Final Office Action mailed on September 29, 2005 was submitted by Appellant to cancel claims 13-21, 38, and 39. *See* Response to Final Office Action, page 7. The Examiner entered this amendment. *See* Advisory

Action mailed December 21, 2005. No other amendments have been submitted or entered subsequent to the Final Office Action mailed on September 29, 2005.

5. SUMMARY OF CLAIMED SUBJECT MATTER

The present application contains two independent claims, namely, claims 1 and 30, both of which have been improperly rejected and, thus, are subject to this Appeal.

The subject matter of these two independent claims is summarized below.

An embodiment of claim 1 generally provides for a process for olefin oligomerization including providing a reaction mixture to a reactor, the reaction mixture having at least a reactant olefin monomer (e.g., ethylene) and a catalyst system suitable for the oligomerization of olefin monomers (e.g., 1-hexene). *See, e.g.*, Application, page 12, lines 5-25. The process further comprises contacting the olefin monomer and the catalyst system in a reaction zone and monitoring an olefin oligomerization reaction by using low-resolution Raman spectrometry equipment to provide an output signal representative of one or more chemical components (e.g., ethylene) of the reaction. *See, e.g.*, Application, page 12, line 25 – page 13, line 31.

An embodiment of claim 30 generally provides for a trimerization process including monitoring a trimerization reaction (e.g., of ethylene) by using Raman spectrometry equipment, wherein the Raman spectrometry equipment comprises low resolution Raman spectrometry equipment (e.g., having a spectral resolution of about 15 cm⁻¹), and recovering 1-hexene from the trimerization reaction. *See, e.g.*, Application,

page 8, lines 10-14; page 9, lines 5-24 ("Spectral resolution for such a spectrometer is about 15 cm⁻¹, which places it in the category of low resolution spectrometry equipment.").

6. GROUNDS OF REJECTIONS TO BE REVIEWED ON APPEAL

First Ground of Rejection:

Appellant respectfully requests that the Board review and reverse the Examiner's first ground of rejection, in which claims 1-5, 8-11, 13-21, 30-33, and 35-39 were rejected under 35 U.S.C. § 103(a) as obvious over Lashier et al. (U.S. Patent No. 5,689,028) in view of Alsmeyer et al. (U.S. Patent No. 5,638,172).

Second Ground of Rejection:

Appellant respectfully requests that the Board review and reverse the Examiner's second ground of rejection, in which claims 12 and 37 were rejected under 35 U.S.C. § 103(a) as being unpatentable over Lashier et al. and Alsmeyer et al. in further view of Tanaka et al. (U.S. Patent No. 5,750,817).

7. **ARGUMENT**

As discussed in detail below, the Examiner has improperly rejected the pending claims. Further, the Examiner has misapplied long-standing and binding legal precedents and principles in rejecting the claims under 35 U.S.C. § 103(a). Accordingly, Appellant

respectfully requests full and favorable consideration by the Board, as Appellant strongly believes that claims 1-5, 8-12, 30-33, and 35-37 are currently in condition for allowance.

First Ground of Rejection

The Examiner rejected claims 1-5, 8-11, 13-21, 30-33, and 35-39 under 35 U.S.C. § 103(a) as obvious over Lashier et al. (U.S. Patent No. 5,689,028) in view of Alsmeyer et al. (U.S. Patent No. 5,638,172). Appellant respectfully traverses this rejection.

Legal Precedent

The burden of establishing a *prima facie* case of obviousness falls on the Examiner. *Ex parte Wolters and Kuypers*, 214 U.S.P.Q. 735 (PTO Bd. App. 1979). To establish a *prima facie* case, the Examiner must show that the modified reference includes *all* of the claimed elements, and provide a convincing line of reason as to why one of ordinary skill in the art would have found the claimed invention to have been obvious in light of the teaching of the reference. *See Ex parte Clapp*, 227 U.S.P.Q. 972 (B.P.A.I. 1985). One cannot use hindsight reconstruction to deprecate the claimed invention. *In re Fine*, 837 F.2d 1071, 5 U.S.P.Q.2d 1596 (Fed. Cir. 1988).

Deficiencies of the Rejection

The Examiner's rejection is insufficient for at least three reasons. First, the cited combination fails to teach all of the features recited in the independent claims. For example, as acknowledged by the Examiner, Lashier fails to disclose the use of Raman

spectroscopy, and the Alsmeyer reference (relied upon to teach the use of Raman spectrometry equipment) does *not* disclose the *resolution* of the Raman equipment or the use of Raman spectroscopy in controlling an olefin oligomerization reaction. *See, e.g.*, Office Action Mailed April 11, 2005, page 4. Second, there is no motivation to modify the Lashier system to incorporate use of Raman spectroscopy, much less to incorporate *low-resolution* Raman spectroscopy. Third, the Examiner impermissibly used hindsight in combining the references as alleged.

Moreover, the Examiner's implicit assertion that the sole difference between the uses of high and low resolution Raman spectroscopy is the selection of "appropriate wavelengths" is not supported by any evidence. The resolution of a Raman spectrometer, which refers to the ability to resolve spectral features, is a pertinent, important, and non-trivial aspect of the device, as taught in the art, as presently disclosed, and as presently claimed.

1. Features of Claims 1 and 30 are Missing from the Cited Combination

Independent claim 1 recites "monitoring an *olefin oligomerization* reaction by using *low-resolution* Raman spectrometry equipment." (Emphasis added). Independent claim 30 recites "monitoring a *trimerization reaction* by using Raman spectrometry equipment, wherein the Raman spectrometry equipment comprises *low resolution* Raman spectrometry equipment." (Emphasis added).

The Examiner has not shown that the Alsmeyer device falls within the category of a *low-resolution device*. *See*, *e.g.*, Application, page 9, lines 23-24. Therefore, the Examiner has not met his burden in demonstrating that the cited combination includes all of the claimed elements. Accordingly, the Examiner has failed to establish a *prima facie* case of obviousness with regard to independent claims 1 and 30, and their dependent claims.

In formulating the rejection, the Examiner stated that it would have been obvious to use the "appropriate wave lengths" to monitor the Lashier process. *See* Final Office Action, page 4. However, the Examiner misses the point. The selection of "appropriate wave lengths" is irrelevant to the question of whether Alsmeyer discloses a low-resolution device.

Any given Raman device possesses a certain resolution capability, placing that device in either the category of a low resolution device or a high resolution device. *See, e.g.*, Application, page 9, lines 23-24 (disclosing that a Raman device having a resolution capability of 15 cm⁻¹ falls in the category of a low resolution device). Appellant believes it is well known in the art that a resolution capability generally greater than 8 cm⁻¹ places the Raman device in the category of a low resolution device. *See, e.g.*, http://www.avaloninst.com/content/ raman_information/glossary.htm (last accessed, March 17, 2006); *see also* http://www.enwaveopt.com/doc/SpectroscopyArticle.pdf

(explaining that high resolution Raman is a resolution less than 6 cm⁻¹) (copy of article provided herewith).

Appellant emphasizes that it is the Examiner's burden, not Appellant's, to show that the Alsmeyer device is a low-resolution device. Again, the Examiner has failed to meet this burden and therefore has not established a *prima facie* case of obviousness.

2. No Reason to Modify Lashier as Suggested by the Examiner

The Examiner proposed to modify the Lashier 1-hexene process to incorporate the Alsmeyer Raman device to monitor the (trimerization) conversion of ethylene to 1-hexene. *See, e.g.*, Final Office Action, page 4. However, the peaks of the trimerization to measure to determine conversion are ethylene and 1-hexene at 1620 cm⁻¹ and 1640 cm⁻¹, respectively. *See, e.g.*, Response to Office Action Mailed April 11, 2005; Application page 4 lines, 3-12. Therefore, since the peaks are so close, one of ordinary skill in the art, without the benefit of the Appellant's disclosure, would dismiss the use of low-resolution Raman spectrometry to measure conversion in the monitoring and control of the Lashier ethylene trimerization process.

Not only has the Examiner failed to show that the Alsmeyer reference discloses a low-resolution instrument as claimed, the Examiner has not shown nor explained how the Alsmeyer reference teaches the applicability of or the ability to use a low-resolution

Raman device in the Lashier process or in the claimed processes. Appellant respectfully submits that that the Examiner has failed to establish a *prima facie* case of obviousness.

3. Improper Combination – Impermissible Hindsight

Apparently, the Examiner believes that because Alsmeyer discloses the use of Raman spectroscopy in a polyester process, the Alsmeyer reference can be paired with any other reference disclosing a different process to render the use of Raman spectroscopy in that different process as obvious. See Final Office Action, pages 3-4 (suggesting that use of Raman in Lashier is obvious because "Alsmeyer discloses that the Raman spectrometry has a lots [sic] of advantages for monitoring chemical processes."). However, Appellant respectfully asserts that the Examiner had no reason to even consider the use of Raman spectroscopy in the Lashier 1-hexene process, other than impermissible hindsight based on Appellant's disclosure. The Federal Circuit has warned that the Examiner must not "fall victim to the insidious effect of a hindsight syndrome wherein that which only the inventor taught is used against its teacher." See In re Dembiczak 50 U.S.P.Q. 2d 52 (Fed. Cir.1999) (quoting W.L. Gore & Assoc., Inc. v. Garlock, Inc., 220 U.S.P.O. 303, 313 (Fed. Cir. 1983)); see also In re Fine, 837 F.2d 1071, 5 U.S.P.Q.2d 1596 (Fed. Cir. 1988) (explaining that one cannot use hindsight reconstruction to pick and choose among isolated disclosures in the prior art to deprecate the claimed invention).

Clearly, without the benefit of Appellant's disclosure, the Examiner (or one of ordinary skill in the art) would *not* know or think it feasible to employ a Raman device, let alone a low resolution Raman device, in the 1-hexene process of Lashier. After all, as discussed below, the Alsmeyer polyester process (a condensation reaction) and the Lashier 1-hexene process (an addition reaction) utilize disparate chemical reactions.

With regard to the specific proposal by the Examiner to measure *conversion* in Lashier with the Alsmeyer Raman, the application of Raman is much easier in the Alsmeyer process than in the Lashier process. The Alsmeyer polymerization reactants and product polymer polyester are dissimilar compounds having dissimilar functional groups that have dissimilar Raman wavelengths, and therefore are relatively straightforward to differentiate and measure, especially with the high resolution Raman spectrometer apparently taught by Alsmeyer. Conversely, in Lashier, the key structural feature of the reactant ethylene and product 1-hexene, the carbon-carbon double bond, has similar wavelengths which make them inherently more difficult to differentiate and measure with Raman spectroscopy, especially by a low resolution Raman spectrometer, as claimed. *See, e.g.*, Application, page 14, lines 3-33.

The present application recognizes the difficulty of differentiating ethylene and 1hexene with low-resolution Raman, stating:

In such cases [with ethylene and 1-hexene], obtaining a calibration model that can distinguish and correct [sic] quantify these components may seem impossible. It has been observed that such a calibration model is obtainable,

though with more difficulty than where the components have peaks that are separate and readily distinguishable. Furthermore, it has been discovered that such a calibration model may be obtained and used even with low resolution Raman spectrometry equipment.

Application, page 15, lines 1-10.

Clearly, the cited combination proposed by the Examiner does <u>not</u> inform one of ordinary skill in the art in the use of *low-resolution* Raman spectroscopy in a *1-hexene process or similar oligomerization process*. Alsmeyer does <u>not</u> teach the capability of differentiating between the Raman peaks of ethylene and 1-hexene, as discussed above. *See* Application, page 4 lines 3-12. Such a modification of either cited reference is clearly <u>not</u> obvious. *See* Final Office Action, page 4; Application, page 4, lines 3-21; page 18, lines 14-34. Again, Appellant respectfully asserts that the Examiner has employed impermissible hindsight in attempting to modify both the Lashier and Alsmeyer references to read on the present claims. *See In re Fine*, 837 F.2d 1071, 5 U.S.P.Q.2d 1596 (Fed. Cir. 1988).

Additionally, the two processes pose different functional relationships between the monomers and products which impact the ability to measure conversion and to control the respective processes. Alsmeyer's process allows one to measure and control, spectroscopically, at least one monomer which has a functional feature (the hydroxy group of the alcohol monomer) different than the functional feature of the resulting product (the ester group of the resultant polyester). In contrast, Lashier's process must be

able to measure, spectroscopically, the difference between the single monomer (ethylene) and a resultant product (1-hexene), which have the same spectroscopic structural feature, a carbon-carbon double bond.

The Alsmeyer process produces a polymer by creating an ester group (which has a dissimilar functional group than at least one of the Alsmeyer monomers) while Lashier's process produces an oligomer by creating two carbon-carbon single bonds while retaining a carbon-carbon double bond (which is also present in the single and only monomer of Lashier). It should also be noted that the Alsmeyer process utilizes two monomers having two dissimilar functional groups (an alcohol and an ester), whereas Lashier's process utilizes a single monomer (ethylene). Therefore, for this reason as well, the Raman approach is radically different in measuring monomer concentration in Alsmeyer as would be done in Lashier. Such differences between Alsmeyer and Lashier clearly impact the ability/configuration of the Raman device in providing "an output signal representative of one or more chemical components of the reaction," as recited in claim 1. Plainly, the Examiner has employed impermissible hindsight, without any teaching or direction except for that of the present disclosure, to justify the combination of Alsmeyer and Lashier.

In sum, the Examiner has not overcome the hindsight gap to explain why one of ordinary skill in the art of *1-hexene production* (an addition reaction employing a single monomer which is difficult to differentiate from the product 1-hexene with Raman)

would look to a *polyester process* (a condensation reaction employing two monomers which are easy to differentiate from the product polyester with Raman and easy to differentiate between themselves with Raman). To be sure, the demands placed upon the Raman spectrometer in *Alsmeyer's polyester process* are very different than the demands that would be placed upon the Raman spectrometer in the *Lashier 1-hexene process*. Appellant stresses that the Examiner has failed to bridge the enormous gap that must be overcome to find motivation to combine Alsmeyer and Lashier, as proposed by the Examiner.

4. Selection of Wavelengths

In the Advisory Action mailed December 21, 2005, the Examiner posited that once the "appropriate wavelengths [are] selected, then the equipment having such a selected wave length would be selected to be used." This statement implicitly recognizes that it is not the wavelength that can be controlled by the skilled artisan, but the equipment utilized, in terms of resolution (among other parameters), that can be specified by the skilled artisan. Therefore, considering the nearness of the "appropriate wavelengths" for the ethylene to 1-hexene trimerization (as previously discussed), the skilled artisan would not select a low-resolution Raman spectrometer to measure ethylene and 1-hexene within the ethylene trimerization process and would in fact choose a high resolution instrument for controlling the ethylene to 1-hexene trimerization process.

The Examiner demonstrates a misunderstanding of the art in implying that the difference between the use of high and low resolution Raman spectroscopy is merely the selection of appropriate wavelengths. Furthermore, the Examiner has provided no evidence, either in the form of references or knowledge known to one of skill in the art, to support the assertion that the only difference in the application of high resolution Raman spectroscopy is the selection of appropriate wavelengths. To explain, Raman spectrometry measures the wavelengths of scattered radiation obtained by irradiating a sample with a source of visible monochromatic radiation. Regardless of the resolution of the Raman instrument, the scattered radiation will have the same wavelengths.

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The resolution of the Raman spectrometer impacts whether or not the instrument can differentiate between two or more peaks of scattered radiation. While, it is true that any particular compound will have multiple wavelengths that can be measured by a Raman spectrometer, not all of these wavelengths may be useful (e.g., for monitoring a process or for measuring a component concentration) due to the overlap of the Raman peaks of other compounds within the process system. Thus, the skilled artisan does not have an infinite number of wavelengths to choose from and may actually be limited to only a few useful wavelengths. For a particular reaction, the useful wavelengths will depend on the reagents and products of the reaction, and it is the resolution of the Raman spectrometer that the skilled artisan can select and control to accommodate the particular demands for monitoring and differentiating the useful wavelengths of any particular chemical process such as an olefin oligomerization process (or trimerization process), as

claimed. Here, the Examiner has not explained the motivation of why one skilled in the art would specify a low-resolution device to monitor the Lashier process. This is especially clear when considering that one of ordinary skill in the art would recognize the difficulties and limitations of utilizing low resolution Raman to monitor an olefin oligomerization process (or trimerization process) which has useful wavelength peaks that are difficult to differentiate using a low resolution Raman spectrometer.

Request Withdrawal of Rejection

In view of the deficiencies of the Lashier and Alsmeyer references discussed above, Appellant respectfully requests that the Board direct the Examiner to withdraw the rejection of claims 1-5, 8-12, 30-33, and 35-37.

Second Ground of Rejection

The Examiner rejected dependent claims 12 and 37 under 35 U.S.C. 103(a) as being unpatentable over Lashier in view of Alsmeyer, et al., and further in view of Tanaka et al. (U.S. Patent No. 5,750,817). Appellant respectfully traverses this rejection. The Tanaka reference does not obviate the deficiencies of the Alsmeyer and Lashier references discussed above with regard to the independent claims. Therefore, rejected claims 12 and 37 are believed to be patentable over the cited combination by virtue of their dependency on an allowable base claim and also because of the subject matter they separately recite. Accordingly, Appellant respectfully requests that the Board direct the Examiner to withdraw the rejection of claims 12 and 37 and allow the claims.

CONCLUSION

If the Examiner or the Board believes that a telephonic interview would assist in the prosecution of the present application to allowance, such an interview with the undersigned is sincerely invited.

Respectfully submitted,

Date: April 17, 2006

John M. Rariden Reg. No. 54,388 FLETCHER YODER P.O. Box 692289

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8. APPENDIX OF CLAIMS ON APPEAL

1. (previously presented) A process for olefin oligomerization in a reactor, the process comprising:

at least one reactant comprising at least one olefin monomer and optionally hydrogen; and

a catalyst system suitable for the oligomerization of olefin monomers; contacting the olefin monomer and the catalyst system in a reaction zone; monitoring an olefin oligomerization reaction by using low-resolution

Raman spectrometry equipment to provide an output signal representative of one or more chemical components of the reaction; and

recovering an oligomer.

- 2. (previously presented) The olefin oligomerization process of claim 1, wherein the output signal is representative of a concentration of one of the reactants or the oligomer.
- 3. (previously presented) The olefin oligomerization process of claim 1, comprising adjusting the olefin oligomerization reaction in response to the output signal provided by the Raman spectrometry equipment.

- 4. (previously presented) The olefin oligomerization process of claim 1, wherein the olefin oligomerization reaction is adjusted by adjusting the amount within the reaction mixture of at least one of the reactants, the oligomer or the catalyst system.
- 5. (previously presented) The olefin oligomerization process of claim 1, wherein the Raman spectrometry equipment is operatively connected to a Raman fiber optic probe that is in contact with the olefin oligomerization reaction or the oligomer.
 - 6. (cancelled).
 - 7. (cancelled).
- 8. (previously presented) The olefin oligomerization process of claim 1, wherein the low resolution Raman spectrometry equipment has a resolution in the range of from about 15 wavenumbers to about 30 wavenumbers.
- 9. (previously presented) The olefin oligomerization process of claim 1, wherein the reactants comprise hydrogen.
- 10. (previously presented) The olefin oligomerization process of claim 1, wherein the oligomerization reaction is a trimerization reaction.

- 11. (previously presented) The olefin oligomerization process of claim 1, wherein the monomer comprises ethylene and the oligomer comprises 1 hexene.
- 12. (previously presented) The olefin oligomerization process of claim 1, wherein the process is performed in two or more reactors connected in series, wherein effluent from an upstream reactor is provided as input to a downstream reactor, wherein the monitoring comprises determining a concentration of the monomer in the effluent by the Raman spectrometry equipment, and comprising adjusting an amount of monomer or component fed to the downstream reactor.
 - 13-29. (cancelled).
 - 30. (previously presented) A trimerization process, the process comprising:
 monitoring a trimerization reaction by using Raman spectrometry equipment,
 wherein the Raman spectrometry equipment comprises low resolution
 Raman spectrometry equipment; and
 recovering 1-hexene from the trimerization reaction.
- 31. (previously presented) The trimerization process of claim 30, comprising adjusting a condition of the trimerization reaction in response to an output signal provided by the Raman spectrometry equipment.

- 32. (previously presented) The trimerization process of claim 31, wherein adjusting the trimerization reaction condition comprises adjusting an amount of an ethylene monomer, a catalyst system, or the 1-hexene, or any combination thereof, in response to the output signal.
- 33. (previously presented) The trimerization process of claim 30, wherein the Raman spectrometry equipment comprises a Raman fiber optic probe adapted to contact the trimerization reaction.
 - 34. (cancelled).
- 35. (previously presented) The trimerization process of claim 30, wherein the low resolution Raman spectrometry equipment has a resolution in the range of from about 15 wavenumbers to about 30 wavenumbers.
- 36. (previously presented) The trimerization process of claim 30, wherein the trimerization reaction comprises ethylene monomer, a catalyst system, and hydrogen.
- 37. (previously presented) The trimerization process of claim 30, wherein the process is performed in two or more reactors connected in series, wherein effluent from an upstream reactor is provided as input to a downstream reactor, wherein the monitoring comprises determining a concentration of an ethylene monomer in the effluent by the

Raman spectrometry equipment, and comprising providing an amount of the ethylene monomer in addition to the effluent to the downstream reactor in response to the determined concentration of the ethylene monomer in the effluent.

- 38. (cancelled).
- 39. (cancelled).

9. APPENDIX OF EVIDENCE

See the attached article entitled "A New Era in Affordable Raman Spectroscopy."

10. APPENDIX OF RELATED PROCEEDINGS

None.

A New Era in Affordable

Raman Spectroscopy

This article overviews several recent advancements in Raman components that are enabling high analytical performance in low-cost Raman instruments.

Tony Lam

uring time, normally a few seconds, is and in aqueous solution. It does not, analysis; the sample can be as small as tool for chemical analysis due to aman spectroscopy is an ideal its unique advantages over other materials, requiring no special sample ples via sample plastic bags, glass vials, 1-2 µm across. A short amount of measrequired to obtain a Raman spectrum. Thus, it can be used to monitorschemianalytical techniques. It is a nondestrucpreparation. Raman can analyze samrequire a large amount of a sample to do tive and noncontacting method of obtaining the fingerprint spectrum of cal reactions in real time.

son is the high cost typically associated Currently, a high-resolution and high signal-to-noise ratio Raman analyzer systems. with Raman analyzer

is not in widespread use. The main reasonable However, those systems usually are can be priced from \$40,000 and above. On the other hand, there is a market general laboratory tools. need for low-cost Raman analyzer sys-

equipped with low-resolution, lowenabling greater acceptance and usage er-resolution and lower-cost Ramar enough to perform any high perform ance chemical analysis. Therefore, be systems are key to increasing of Raman spectroscopy.

tion and low cost. Finally, Raman appli-Despite the fact that Raman spec- pharmaceutical petrochemical process-troscopy has so many advantages it still in in, and plastic recycling applications advancements in Raman components that will enable low costs and high percations and sample Raman spectra in ormance. It also establishes the figure This article presents a few key Raman systems in terms of high resolu of merit to identify and characterize

Modern Raman Systems

tion device, the spectrograph, and the A typical laboratory Raman analyzer system consists of four major components: the excitation source, the collecpost-processing software. The excitagenerate sufficient Raman signals, and

CO.

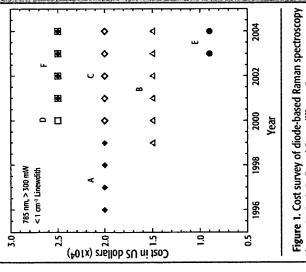
Tony Lam is a senior system engineer at EnWave Optronics (Irvine, CA). He can be reached at: tlam@enwaveopt.com.

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ed data then are passed to scattered photons, filters transfers them to the light detector, which records the ed photons at its own wavelength. These recordmonochromatic light to provide clean and uncomplicated spectra. A laser monochromatic light with high intensity. The collection device is the fiberoptic probe. It collects the out the Rayleigh scattering, and sends the Raman sigarates the Raman signals by their wavelengths and intensity of the accumulattypically is used as the excitation source because it can The spectrograph then sepprovide a coherent beam of nals to the spectrograph.

Several types of lasers can be used as troscopy. They are Ar+ ion (488.0 and candidate to be utilized in low-cost, the excitation source for Raman specnm), He:Ne (632.8 nm), Nd:YAG (1064 lasers (1). Due to recent advancements nm), and diode (630 and 980 nm) in diode laser technology, it is the best 514.5 nm), Kr+ ion (530.9 and 647.1 ware to display as a Raman spectrum. the postprocessing soft-

pact size, high reliability (>10,000-h portable Raman analyzer systems emission wavelength for fluorescence reduction. A typical diode laser used in a modern Raman analyzer system is a with wavelengths ranging from 630 to because of its relatively low cost, comifetime), and near-infrared (NIR) high power laser diode (>300 mW),



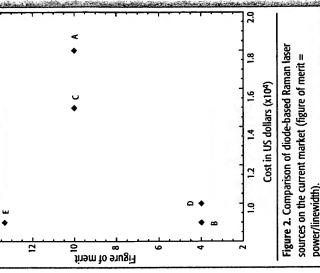
lasers (A, B, C, D, E, and F are different Raman spectroscopy laser manufacturers)

past few years because of their coverage of meanly 3000-cm. useful spectration when based upon a silicon chargedpreferred. Thus, diode lasers emitting at 785 nm (NIR) generally have been rec-For any high resolution (<6 cm⁻¹) ally <1 cm⁻¹) of the excitation source plays a key role. Also, to avoid fluorescence interference, NIR wavelengths are ognized as the industry standard in the coupled device (CCD) detector. *Raman system, the laser linewidth (ide*

Unfortunately, without any 'frequency'. stabilization and linewidth narrowing, these diode lasers cannot be used in a nigh-resolution Raman system because of their free running spectral linewidth of ~25 cm⁻¹ and unstable center waveength that causes random shifts in Raman spectra.

(ASE) remove the unwanted ASE interference that often is seen in a high-power diode diode laser wavelength stabirowing have been very drastabilization designs include gratings, volume Bragg gratings, distributed feedback lasers (DFBs), distributed lasers (DBRs), and master oscillator power amplifier lasers (MOPAs). Some designs laser. All these lasers should Recent developments in matic. Current wavelength gratings, Littmann with traditional gratings, fiber Bragg ter or amplified spontareduction technique to ization and linewidth nar-Littrow with traditional also integrate a bandpass filreflector emission neoùs Bragg

within a tenth of a wavenumber, and a two responses (laser linewidth and speca high-resolution Raman system. A laser trometer's resolution is not ideal because the system's overall spectral profile or esponse will be the convolution of the will affect the overall system spectral profile and cause inaccuracies in chemolength-stabilized, 785-nm, 300-mW, 1cm-1 linewidth Raman spectroscopy power, a stabilized center wavelength spectral linewidth of less than 1, cm-1 for linewidth (~3-4 cm-1) close to the specfrometer's resolution). Thus, any laser spectral profile changes due to temperature, current, or any other nonlinearities metric prediction. Figure 1 depicts a cost survey over the past eight years for wavein optical at least provide 150 mW



power/linewidth)

silicon CCD camera, the CCD sensor has replaced the single channel detector, to 1700 nm (2). In addition, the CCD sensor, will reduce integration time Due to the recent development of a photomultiplier tube (PMT) and avagraph. It can detect radiation from 400 because it allows spectrum multiplexing. A typical integration time of the CCD lanche photodiodes (APD), as a multichannel photon detector in the spectro-

A general laboratory Raman probe is composed of two fibers. The excitation fiber is used to deliver the excitation source to a sample. The collection fiber is used to collect Raman signals and the spectrograph. oand-reject filter are integrated Normally, the bandpass filter spectrograph is less than 30 s. deliver it to

aser systems on the market.

the fiber-optic probe head to remove the laser Rayleigh scattering, silica Raman interference from the fiber, and ASE from the laser excitation source.

The data collected from the spectrograph then are sent to the software. The software then converts the data into the Raman spectrum and displays it on an *x*-*y* chart. The *x* axis of the chart is the wavenumber, while the *y* axis is the intensity of the spectrum.

Resolution of Raman Systems

Three basic bandpass filters are used in a typical Raman measuring system to determine the overall Raman

spectrum quality (that is, resolution). These three bandpass filters are: laser linewidth bandpass, spectrometer bandpass, and sample bandpass (natural linewidth) filters.

Ideally, a laser linewidth bandpass filter should be much less than the spectrometer bandpass filter. In this case, the spectrometer will be the only factor in determining the Raman system's bandpass filter. If the bandpass filters of the two (that is, laser and

tem's bandpass filter. If the bandpass filters of the two (that is, laser and spectrometer) are close, the system's bandpass filter will be a convolutional bandpass filter of the two components. Generally, a spectrometer bandpass filter's profile is much more stable than the laser bandpass filter profile, thus a much narrower laser linewidth bandpass filter is preferred and could make

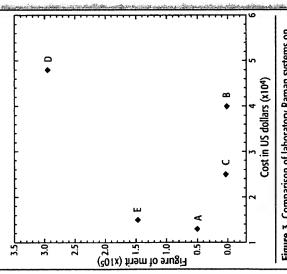


Figure 3. Comparison of laboratory Raman systems on the current market (figure of merit = [coverage x power]/[resolution]).

For most Raman applications in solid and liquid samples, a system resolution of 6 cm⁻¹ or less is sufficient.

Unfortunately, any high-resolution (<6 cm⁻¹) Raman system usually is highly priced primarily because of the high cost of the high power in the bigh cost of the high power solved (>300 mW), wavelength-stabilized, and linewidth narrowed (<1 cm⁻¹).

Raman spectroscopy laser.

Costs of Raman Systems

To compare the cost of different Raman systems currently on the market, a ligure of merit is adopted as a way to normalize different features and performances for a fair comparison. The higher the figure of merit, the better the system's performance. This section of the article compares the costs of the laser sources and the overall Raman systems. The cost

of laser sources is compared because the laser still is the major cost component for a Raman system. The figure of merit of the laser is defined as the laser power inversed proportionally with the laser linewidth:

Figure of merit = power/linewidth [1]
Using Equation 1, the

figures of merit of lasers (A-E) are calculated and mapped in Figure 2.
Observing the figure-of-

Observing the figure-of-merit chart (Figure 2), the laser excitation sources are divided into three groups. One group is the high performance and high cost group, including A and C

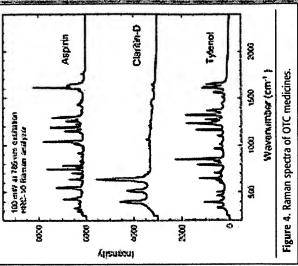
Jaser sources. The second group is the low-performance and low-cost group, including B and D laser sources. The last group, E laser sources, is the high performance and low cost group.

The figure of merit of the Raman system is defined as the product of the spectral range (coverage) and the laser power divided by the system resolution:

Figure of merit = (coverage x power)/(resolution) [2]

Using Equation 2, the figures of meritiof Raman systems (A+E) are calculated and mapped in Figure 3.

Observing the figure-of-merit chart of the Raman system (Figure 3), the A and E Raman system are considered to be the medium-performance and lowcost systems. The B and C systems are considered to be low-performance and high-cost systems. The D system is considered a high-end system, high performance versus high cost. It is the



s the Raman spectroscopy applications that coup, determine which Raman systems should The be used, but for most of the applications, high a Raman system that has a 6-cm⁻¹ spec-

Applications of Affordable Raman Systems

tral resolution is sufficient (1).

With high-resolution and low-cost x. Raman systems, many Raman spectroscopy applications in chemical analysis become feasible. To name a few, Raman spectroscopy is useful in drug identification for the pharmaceutical identification for the pharmaceutical formulatry, the control of octane level in A. Gasoline, and the classification of plastic in the plastic recycling industry. To demonstrate the feasibility of using a low-cost Raman instrument in these applications, the HRC-10 Raman analyzer with less than 6-cm⁻¹ system resolution, manufactured by EnWave

a system much more stable.

Optronics, was chosen to collect Raman

ed isooctane levels of counter medicines, unleadspectra of some over-thegasoline, some plastic samples. Chevron

vibration study for the characterization of the solid Pharmaceutical. One of its application in lattice the advantages of the Raman system is its ability the spectra of drug lattices Raman spectroscopy finds to measure down to compared to the mid-IR system that can only reach approximately 400 cm⁻¹. The feature is very attractive industry because most of state of a drug and especial-50 cm-1 in spectral range pharmaceutical are below 200 cm⁻¹ (3). to the

ly for the investigation of polymorquantification of drug blends, and in the phism and amorphous systems. In addition, it finds application in analysis and examination of drug formulations and drug excipient incompatibilities.

quality of engine antiknocking. Raman ty of petroleum fuel that defines the (4) content added to improve the octane number. The octane number is Also, Raman systems can be used to Petrochemical. The gasoline pur chased from any local gas station has an experimentally determined properexample of the octane level in Chevron unleaded gasoline is shown in Figure 5. measure oxygenate material in the the U.S. the methyl-tert-butyl ether (MTBE) According to

100-mW at 785-cm availation HRC-10 Remon analysis Unleaded 87 Unleaded 89 Unleaded 91 Figure 5. Raman spectra of Chevron unleaded gasoline 8 Waversumber (cm. 1) 3 Ş 803 88 8 5 hienstal

with various isooctane levels.

ment entity requires the use of oxygenate level accurately in the gasoline. of oxygenate materials bon monoxide in the air, the governpetroleum manufacturers have been maintaining and monitoring the oxyduring refinery process. Raman spectroscopy systems have been a favored (EPA) (3), to reduce the levels of cargenate additives to the gasoline, The approach for qualitative identification Environmental Protection Agency of oxygenate materials.

spectroscopy can be used to identify? Plastics consist of seven different kinds the octane level within gasoline.—An of polymers.—They are polyethylene. number 1 under recycling symbol); high density polyethylene (HDPE, 2); polyvinył chloride (PVC, 3); low densiand vastly in many common materials. terephthalate. (labeled as PET, and ly polyethylene (LDPE, 4); polypropy-

application in real-time melt streams, and in plastic identification for recycling purposes. Figure 6 ene (PP, 5); polystyrene labeled as 7 (5). In the spectroscopy systems find monitoring of polymerization reactions to control the processing time, in quantitative compositional analysis of polymer shows an example of plasplastics industry, Raman 6); and "other," tic Raman spectra.

Pohyropylene

5030

8

\$

2

thlensily

Polystyrene

\$

8

8

8

8

Wavenumber (cmr*)

100 mild at 700-cm explait HRC-10 Ramon analyze

38

Conclusion

been advancements in diode laser technology, Raman improved on two fronts: have systems *With

Figure 6. Raman spectra of polypropylene and

polystyrene plastics.

Perhaps within five years, if will find itself within many potential applicacost and resolution. Raman excitation cost. In addition, laser wavelength stabilizing and linewidth narrowing have ments have eliminated the high costs associated with the high-resolution ogy to every corner of life. It signifies a new era in Raman spectroscopy. sources now can be made with a lower improved the resolution of Raman systems. Consequently, these advance system and brought this novel technol

tions_that_have_not_been_considered Tpreviously for chemical analysis:

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(http://www.chembio.uoguelph.ca; How it Works the Spectrum,' accessed 4/29/04). ■

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